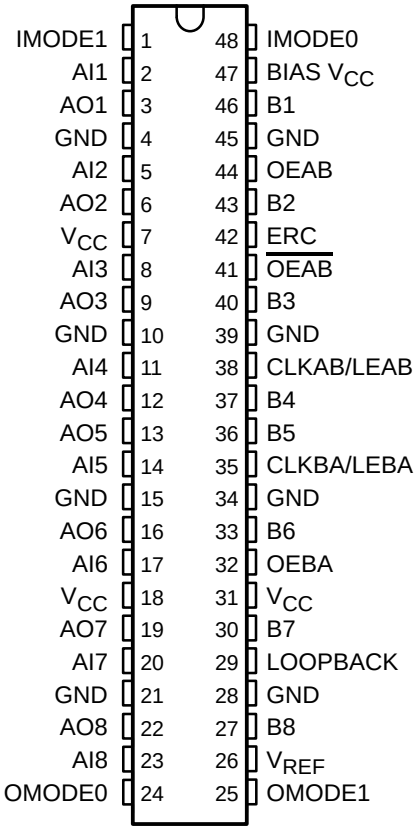
- **Member of the Texas Instruments Widebus™ Family**
- **TI-OPC™ Circuitry Limits Ringing on Unevenly Loaded Backplanes**
- **OEC™ Circuitry Improves Signal Integrity and Reduces Electromagnetic Interference**
- **Bidirectional Interface Between GTLP Signal Levels and LVTTL Logic Levels**
- **Split LVTTL Port Provides a Feedback Path for Control and Diagnostics Monitoring**
- **AO Outputs Have Equivalent 26-Ω Series Resistors, So No External Resistors Are Required**
- **LVTTL Interfaces Are 5-V Tolerant**
- **High-Drive GTLP Open-Drain Outputs (100 mA)**
- **Reduced LVTTL Outputs (–12 mA/12 mA)**
- **Variable Edge-Rate Control (ERC) Input Selects GTLP Rise and Fall Times for Optimal Data-Transfer Rate and Signal Integrity in Distributed Loads**
- **I_{off}, Power-Up 3-State, and BIAS V_{CC} Support Live Insertion**
- **Distributed V_{CC} and GND Pins Minimize High-Speed Switching Noise**
- **Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II**
- **ESD Protection Exceeds JESD 22**
  - **2000-V Human-Body Model (A114-A)**
  - **200-V Machine Model (A115-A)**
  - **1000-V Charged-Device Model (C101)**

DGG OR DGV PACKAGE
(TOP VIEW)



description

The SN74GTLP22033 is a high-drive, 8-bit, three-wire registered transceiver that provides inverted LVTTL-to-GTLP and GTLP-to-LVTTL signal-level translation. The device allows for transparent, latched, and flip-flop modes of data transfer with separate LVTTL input and LVTTL output pins, which provides a feedback path for control and diagnostics monitoring, the same functionality as the SN74FB2033. The device provides a high-speed interface between cards operating at LVTTL logic levels and a backplane operating at GTLP signal levels. High-speed (about three times faster than standard LVTTL or TTL) backplane operation is a direct result of GTLP's reduced output swing (<1 V), reduced input threshold levels, improved differential input, OEC™ circuitry, and TI-OPC™ circuitry. Improved GTLP OEC and TI-OPC circuits minimize bus-settling time and have been designed and tested using several backplane models. The high drive allows incident-wave switching in heavily loaded backplanes with equivalent load impedance down to 11 Ω.

The AO outputs, which are designed to sink up to 12 mA, include equivalent 26-Ω resistors to reduce overshoot and undershoot.

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description (continued)

GTLP is the Texas Instruments derivative of the Gunning Transceiver Logic (GTL) JEDEC standard JESD 8-3. The ac specification of the SN74GTLP22033 is given only at the preferred higher noise margin GTLP, but the user has the flexibility of using this device at either GTL (V_{TT} = 1.2 V and V_{REF} = 0.8 V) or GTLP (V_{TT} = 1.5 V and V_{REF} = 1 V) signal levels. For information on using GTLP devices in FB+/BTL applications, refer to TI application reports, *Texas Instruments GTLP Frequently Asked Questions*, literature number SCEA019, and *GTLP in BTL Applications*, literature number SCEA017.

Normally, the B port operates at GTLP signal levels. The A-port and control inputs operate at LVTTL logic levels, but are 5-V tolerant and can be directly driven by TTL or 5-V CMOS devices. V_{REF} is the B-port differential input reference voltage.

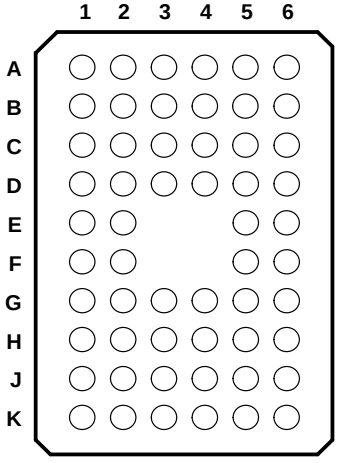
This device is fully specified for live-insertion applications using I_{off}, power-up 3-state, and BIAS V_{CC}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict. The BIAS V_{CC} circuitry precharges and preconditions the B-port input/output connections, preventing disturbance of active data on the backplane during card insertion or removal, and permits true live-insertion capability.

This GTLP device features TI-OPC circuitry, which actively limits overshoot caused by improperly terminated backplanes, unevenly distributed cards, or empty slots during low-to-high signal transitions. This improves signal integrity, which allows adequate noise margin to be maintained at higher frequencies.

High-drive GTLP backplane interface devices feature adjustable edge-rate control (ERC). Changing the ERC input voltage between low and high adjusts the B-port output rise and fall times. This allows the designer to optimize system data-transfer rate and signal integrity to the backplane load.

When V_{CC} is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, $\overline{OEAB}$ should be tied to V_{CC} through a pullup resistor and OEAB and OEBA should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

GQL PACKAGE
(TOP VIEW)



terminal assignments

	1	2	3	4	5	6
A	IMODE1	NC	NC	NC	NC	IMODE0
B	AO1	AI1	GND	GND	BIAS V_{CC}	B1
C	AO2	AI2	V_{CC}	ERC	OEAB	B2
D	AO3	AI3	GND	GND	$\overline{OEAB}$	B3
E	AO4	AI4			CLKAB/LEAB	B4
F	AO5	AI5			CLKBA/LEBA	B5
G	AO6	AI6	GND	GND	OEBA	B6
H	AO7	AI7	V_{CC}	V_{CC}	LOOPBACK	B7
J	AO8	AI8	GND	GND	V_{REF}	B8
K	OMODE0	NC	NC	NC	NC	OMODE1

NC = No internal connection

ORDERING INFORMATION

T_A	PACKAGE†		ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	TSSOP – DGG	Tape and reel	SN74GTLP22033DGGR	GTLP22033
	TVSOP – DGV	Tape and reel	SN74GTLP22033DGVR	GT22033
	VFBGA – GQL	Tape and reel	SN74GTLP22033GQLR	GS033

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

functional description

The SN74GTLP22033 is a high-drive (100 mA), 8-bit, three-wire registered transceiver containing D-type latches and D-type flip-flops for data-path operation in the transparent, latched, or flip-flop modes. Data transmission is complementary, with inverted AI data going to the B port and inverted B data going to AO. The split LVTTL AI and AO provides a feedback path for control and diagnostics monitoring.

The logic element for data flow in each direction is configured by two mode (IMODE1 and IMODE0 for B to A, OMODE1 and OMODE0 for A to B) inputs as a buffer, a D-type flip-flop, or a D-type latch. When configured in the buffer mode, the inverted input data appears at the output port. In the flip-flop mode, data is stored on the rising edge of the appropriate clock (CLKAB/LEAB or CLKBA/LEBA) input. In the latch mode, the clock inputs serve as active-high transparent latch enables.

Data flow in the B-to-A direction, regardless of the logic element selected, is further controlled by the LOOPBACK input. When LOOPBACK is low, B-port data is the B-to-A input. When LOOPBACK is high, the output of the selected A-to-B logic element (prior to inversion) is the B-to-A input.

The AO enable/disable control is provided by OEBA. When OEBA is low or when V_{CC} is less than 1.5 V, AO is in the high-impedance state. When OEBA is high, AO is active (high or low logic levels).

The B port is controlled by OEAB and $\overline{\text{OEAB}}$. If OEAB is low, $\overline{\text{OEAB}}$ is high, or V_{CC} is less than 1.5 V, the B port is inactive. If OEAB is high and $\overline{\text{OEAB}}$ is low, the B port is active.

The A-to-B and B-to-A logic elements are active, regardless of the state of their associated outputs. The logic elements can enter new data (in flip-flop and latch modes) or retain previously stored data while the associated outputs are in the high-impedance (AO) or inactive (B port) states.

Function Tables

FUNCTION/MODE

INPUTS								OUTPUT	MODE
OEBA	OEAB	$\overline{OEAB}$	OMODE1	OMODE0	IMODE1	IMODE0	LOOPBACK		
L	L	X	X	X	X	X	X	Z	Isolation
L	X	H	X	X	X	X	X		
X	H	L	L	L	X	X	X	Inverted AI to B	Buffer
X	H	L	L	H	X	X	X		Flip-flop
X	H	L	H	X	X	X	X		Latch
H	L	X	X	X	L	L	L	Inverted B to AO	Buffer
H	X	H	X	X	L	L	L		
H	L	X	X	X	L	H	L	Inverted B to AO	Flip-flop
H	X	H	X	X	L	H	L		
H	L	X	X	X	H	X	L	Inverted B to AO	Latch
H	X	H	X	X	H	X	L		
H	L	X	X	X	L	L	H	AI to AO	Buffer
H	X	H	X	X	L	L	H		
H	L	X	X	X	L	H	H	AI to AO	Flip-flop
H	X	H	X	X	L	H	H		
H	L	X	X	X	H	X	H	AI to AO	Latch
H	X	H	X	X	H	X	H		
H	H	L	X	X	X	X	L	Inverted AI to B, Inverted B to AO	Transparent with feedback path

ENABLE/DISABLE

INPUTS			OUTPUTS	
OEBA	OEAB	$\overline{OEAB}$	AO	B
L	X	X	Z	
H	X	X	Active	
X	L	L		Z
X	L	H		Z
X	H	L		Active
X	H	H		Z

BUFFER

INPUT	OUTPUT
L	H
H	L

LATCH

INPUTS		OUTPUT
CLK/LE	DATA	
H	L	H
H	H	L
L	X	Q_0

Function Tables (Continued)

LOOPBACK

LOOPBACK	Q†
L	B port
H	Point P‡

† Q is the input to the B-to-A logic element.
‡ P is the output of the A-to-B logic element (see functional block diagram).

SELECT

INPUTS		SELECTED LOGIC ELEMENT
MODE1	MODE0	
L	L	Buffer
L	H	Flip-flop
H	X	Latch

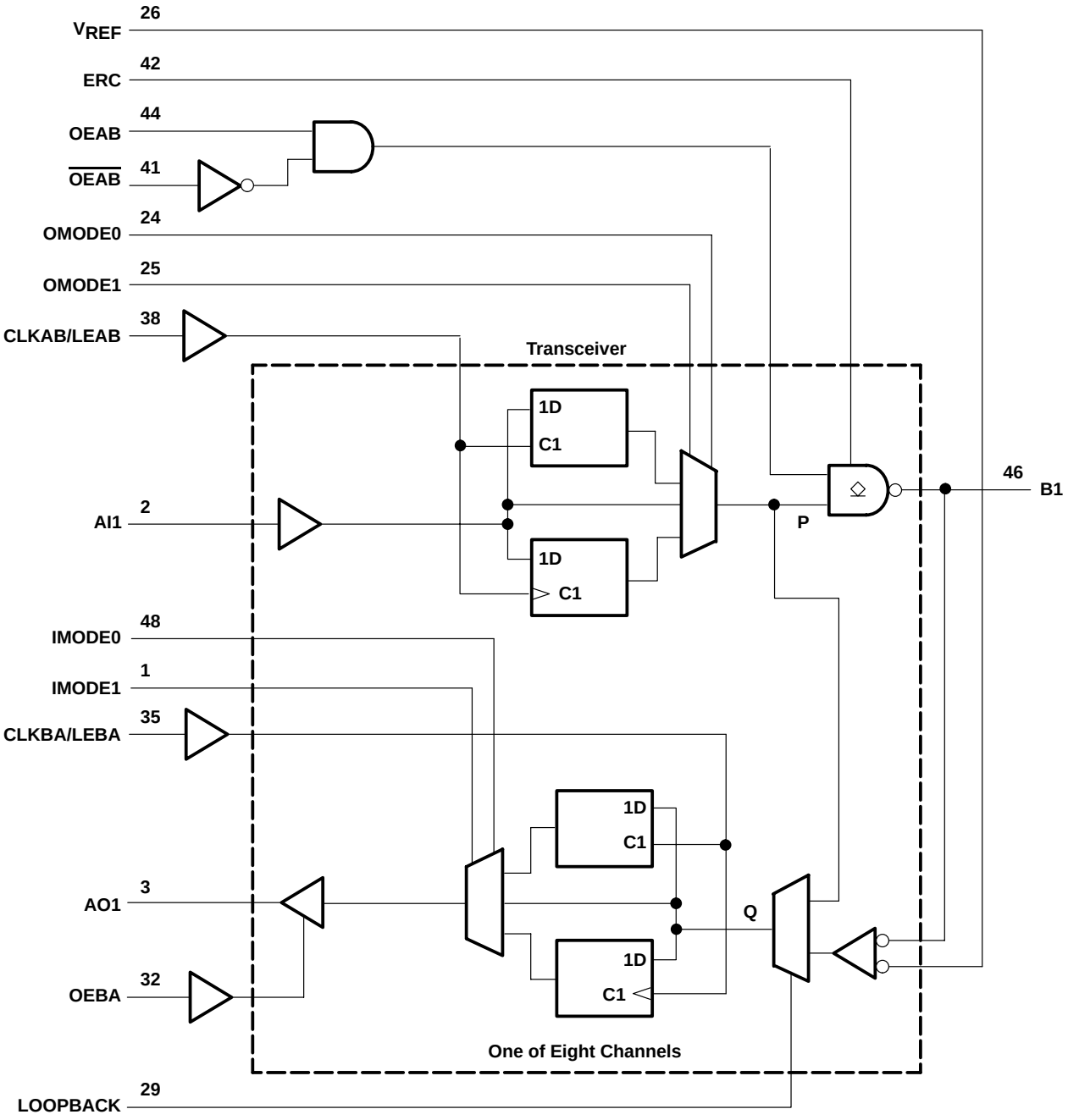
FLIP-FLOP

INPUTS		OUTPUT
CLK/LE	DATA	
L	X	Q_0
↑	L	H
↑	H	L

B-PORT EDGE-RATE CONTROL (ERC)

INPUT ERC	OUTPUT B-PORT EDGE RATE
LOGIC LEVEL	
H	Slow
L	Fast

functional block diagram



Pin numbers shown are for the DGG and DGV packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} and BIAS V_{CC} . . . . . –0.5 V to 4.6 V
Input voltage range, V_I (see Note 1): AI port, ERC, and control inputs . . . . . –0.5 V to 7 V
B port and V_{REF} . . . . . –0.5 V to 4.6 V
Voltage range applied to any output in the high-impedance or power-off state, V_O
(see Note 1): AO port . . . . . –0.5 V to 7 V
B port . . . . . –0.5 V to 4.6 V
Current into any output in the low state, I_O: AO port . . . . . 24 mA
B port . . . . . 200 mA
Current into any A-port output in the high state, I_O (see Note 2) . . . . . 24 mA
Continuous current through each V_{CC} or GND . . . . . ±100 mA
Input clamp current, I_{IK} ($V_I < 0$) . . . . . –50 mA
Output clamp current, I_{OK} ($V_O < 0$) . . . . . –50 mA
Package thermal impedance, θ_{JA} (see Note 3): DGG package . . . . . 70°C/W
DGV package . . . . . 58°C/W
GQL package . . . . . 42°C/W
Storage temperature range, T_{stg} . . . . . –65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. This current flows only when the output is in the high state and $V_O > V_{CC}$.
3. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Notes 4 through 7)

			MIN	NOM	MAX	UNIT
V_{CC}, BIAS V_{CC}	Supply voltage		3.15	3.3	3.45	V
V_{TT}	Termination voltage	GTL	1.14	1.2	1.26	V
		GTLP	1.35	1.5	1.65	
V_{REF}	Reference voltage	GTL	0.74	0.8	0.87	V
		GTLP	0.87	1	1.1	
V_I	Input voltage	B port			V_{TT}	V
		Except B port and V_{REF}		V_{CC}	5.5	
V_{IH}	High-level input voltage	B port	V_{REF}+0.05			V
		Except B port	2			
V_{IL}	Low-level input voltage	B port			V_{REF}–0.05	V
		Except B port			0.8	
I_{IK}	Input clamp current				–18	mA
I_{OH}	High-level output current	AO			–12	mA
I_{OL}	Low-level output current	AO			12	mA
		B port			100	
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled			10	ns/V
$\Delta t/\Delta V_{CC}$	Power-up ramp rate		20			μs/V
T_A	Operating free-air temperature		–40		85	°C

NOTES: 4. All unused control and B-port inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

5. Proper connection sequence for use of the B-port I/O precharge feature is GND and BIAS V_{CC} = 3.3 V first, I/O second, and V_{CC} = 3.3 V last, because the BIAS V_{CC} precharge circuitry is disabled when any V_{CC} pin is connected. The control and V_{REF} inputs can be connected anytime, but normally are connected during the I/O stage. If B-port precharge is not required, any connection sequence is acceptable but, generally, GND is connected first.

6. V_{TT} and R_{TT} can be adjusted to accommodate backplane impedances if the dc recommended I_{OL} ratings are not exceeded.

7. V_{REF} can be adjusted to optimize noise margins, but normally is two-thirds V_{TT}. TI-OPC circuitry is enabled in the A-to-B direction and is activated when V_{TT} > 0.7 V above V_{REF}. If operated in the A-to-B direction, V_{REF} should be set to within 0.6 V of V_{TT} to minimize current drain.

electrical characteristics over recommended operating free-air temperature range for GTLP (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V_{IK}		V_{CC} = 3.15 V,	I_I = –18 mA			–1.2	V
V_{OH}	AO	V_{CC} = 3.15 V to 3.45 V,	I_{OH} = –100 μA	V_{CC}–0.2			V
		V_{CC} = 3.15 V	I_{OH} = –6 mA	2.4			
			I_{OH} = –12 mA	2			
V_{OL}	AO	V_{CC} = 3.15 V to 3.45 V,	I_{OL} = 100 μA			0.2	V
		V_{CC} = 3.15 V	I_{OL} = 6 mA			0.55	
			I_{OL} = 12 mA			0.8	
	B port	V_{CC} = 3.15 V	I_{OL} = 10 mA			0.2	
			I_{OL} = 64 mA			0.4	
			I_{OL} = 100 mA			0.55	
I_I‡	AI and control inputs	V_{CC} = 3.45 V,	V_I = 0 or 5.5 V			±10	μA
I_{OZ}‡	AO	V_{CC} = 3.45 V,	V_O = 0 to 5.5 V			±10	μA
	B port	V_{CC} = 3.45 V, V_{REF} within 0.6 V of V_{TT},	V_O = 0 to 2.3 V			±10	
I_{CC}	AO or B port	V_{CC} = 3.45 V, I_O = 0, V_I (A-port or control input) = V_{CC} or GND, V_I (B port) = V_{TT} or GND	Outputs high			40	mA
			Outputs low			40	
			Outputs disabled			40	
ΔI_{CC}§		V_{CC} = 3.45 V, One AI or control input at V_{CC} – 0.6 V, Other AI or control inputs at V_{CC} or GND				1.5	mA
C_i	AI	V_I = 3.15 V or 0			3.5	4.5	pF
	Control inputs				3.5	5.5	
C_o	AO	V_O = 3.15 V or 0			5	6	pF
C_{io}	B port	V_O = 1.5 V or 0			8.5	10	pF

† All typical values are at V_{CC} = 3.3 V, T_A = 25°C.
‡ For I/O ports, the parameter I_{OZ} includes the input leakage current.
§ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

hot-insertion specifications for A port over recommended operating free-air temperature range

PARAMETER	TEST CONDITIONS			MIN	MAX	UNIT
I_{off}	V_{CC} = 0,	V_I or V_O = 0 to 5.5 V			10	μA
I_{OZPU}	V_{CC} = 0 to 1.5 V,	V_O = 0.5 V to 3 V,	OEBA = V_{CC}		±30	μA
I_{OZPD}	V_{CC} = 1.5 V to 0,	V_O = 0.5 V to 3 V,	OEBA = V_{CC}		±30	μA

live-insertion specifications for B port over recommended operating free-air temperature range

PARAMETER	TEST CONDITIONS			MIN	MAX	UNIT
I_{off}	V_{CC} = 0,	BIAS V_{CC} = 0,	V_I or V_O = 0 to 1.5 V		10	μA
I_{OZPU}	V_{CC} = 0 to 1.5 V, BIAS V_{CC} = 0, V_O = 0.5 V to 1.5 V, $\overline{OEAB}$ = 0 and OEAB = V_{CC}				±30	μA
I_{OZPD}	V_{CC} = 1.5 V to 0, BIAS V_{CC} = 0, V_O = 0.5 V to 1.5 V, $\overline{OEAB}$ = 0 and OEAB = V_{CC}				±30	μA
I_{CC} (BIAS V_{CC})	V_{CC} = 0 to 3.15 V	BIAS V_{CC} = 3.15 V to 3.45 V,	V_O (B port) = 0 to 1.5 V		5	mA
	V_{CC} = 3.15 V to 3.45 V				10	μA
V_O	V_{CC} = 0,	BIAS V_{CC} = 3.3 V,	I_O = 0	0.95	1.05	V
I_O	V_{CC} = 0,	BIAS V_{CC} = 3.15 V to 3.45 V,	V_O (B port) = 0.6 V	–1		μA

timing requirements over recommended ranges of supply voltage and operating free-air temperature, V_{TT} = 1.5 V and V_{REF} = 1 V for GTLP (unless otherwise noted)

			MIN	MAX	UNIT
f_{clock}	Clock frequency			175	MHz
t_w	Pulse duration	CLKAB/LEAB or CLKBA/LEBA	2.8		ns
t_{su}	Setup time	AI before CLKAB↑	1.1		ns
		AI before CLKBA↑	1.4		
		B before CLKBA↑	1		
		AI before LEAB↓	1.6		
		AI before LEBA↓	2.1		
		B before LEBA↓	2.2		
t_h	Hold time	AI after CLKAB↑	0.3		ns
		AI after CLKBA↑	0.2		
		B after CLKBA↑	0.6		
		AI after LEAB↓	0.3		
		AI after LEBA↓	0		
		B after LEBA↓	0		

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, V_{TT} = 1.5 V and V_{REF} = 1 V for GTLP (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATE†	MIN	TYP‡	MAX	UNIT
f_{max}				175			MHz
t_{PLH}	AI (buffer)	B	Slow	3		7.4	ns
t_{PHL}				3		7.1	
t_{PLH}	AI (buffer)	B	Fast	2		5.9	ns
t_{PHL}				2		5.8	
t_{PLH}	B (buffer)	AO	–	1		6.1	ns
t_{PHL}				1		5.4	
t_{PLH}	LEAB (latch mode)	B	Slow	4.2		8.6	ns
t_{PHL}				3.2		7.7	
t_{PLH}	LEAB (latch mode)	B	Fast	3.2		7.6	ns
t_{PHL}				2.8		6.7	
t_{PLH}	LEAB (latch mode)	AO	–	2		7.3	ns
t_{PHL}				1.8		6.6	
t_{PLH}	LEBA (latch mode)	AO	–	1		6	ns
t_{PHL}				1		5.2	
t_{PLH}	OEAB	B	Slow	3.8		7.5	ns
t_{PHL}				3.1		7	
t_{PLH}	OEAB	B	Fast	2.5		6	ns
t_{PHL}				2.5		6	
t_{PLH}	$\overline{OEAB}$	B	Slow	3.5		7.5	ns
t_{PHL}				3		7.2	
t_{PLH}	$\overline{OEAB}$	B	Fast	2.5		6	ns
t_{PHL}				2.5		6	
t_{PZH}	OEBA	AO	–	1		5.3	ns
t_{PZL}				1		4.2	
t_{PHZ}	OEBA	AO	–	1		5.5	ns
t_{PLZ}				1		5.2	
t_{PLH}	CLKAB (flip-flop mode)	B	Slow	4.4		8.8	ns
t_{PHL}				3.6		8.1	
t_{PLH}	CLKAB (flip-flop mode)	B	Fast	3.2		7.2	ns
t_{PHL}				3.1		6.9	
t_{PLH}	CLKAB (flip-flop mode)	AO	–	2		7.5	ns
t_{PHL}				1.8		7	
t_{PLH}	CLKBA (flip-flop mode)	AO	–	1		6	ns
t_{PHL}				1		5.6	
t_{PLH}	OMODE	B	Slow	3.8		8.7	ns
t_{PHL}				3.2		8.2	
t_{PLH}	OMODE	B	Fast	2.7		7.2	ns
t_{PHL}				2.7		7.2	
t_{PLH}	IMODE	AO	–	1		6	ns
t_{PHL}				1		5.1	

† Slow (ERC = H) and Fast (ERC = L)
‡ All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, V_{TT} = 1.5 V and V_{REF} = 1 V for GTLP (see Figure 1) (continued)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATE†	MIN	TYP‡	MAX	UNIT
t_{PLH}	LOOPBACK	AO	–	2.5		6.8	ns
t_{PHL}				2		5.4	
t_{PLH}	AI (loopback high)	AO	–	1		6	ns
t_{PHL}				1		5.5	
t_r	Rise time, B-port outputs (20% to 80%)		Slow		2.8		ns
			Fast		1.5		
	Rise time, AO (10% to 90%)				5.5		
t_f	Fall time, B-port outputs (80% to 20%)		Slow		3		ns
			Fast		1.8		
	Fall time, AO (90% to 10%)				4.5		

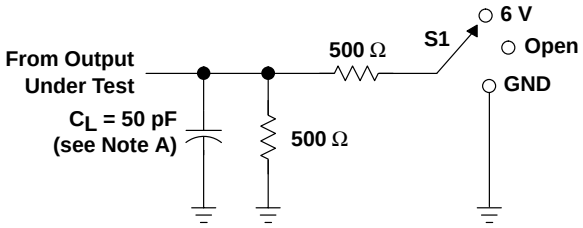
† Slow (ERC = H) and Fast (ERC = L)
‡ All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

skew characteristics over recommended ranges of supply voltage and operating free-air temperature (see Figure 1)§

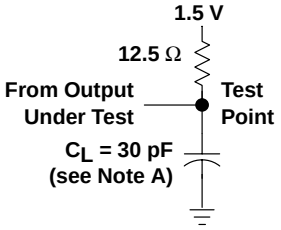
PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATE†	MIN	TYP‡	MAX	UNIT
$t_{sk(LH)}$¶	AI	B	Slow		0.5	1	ns
$t_{sk(HL)}$¶					0.5	1	
$t_{sk(LH)}$¶	AI	B	Fast		0.4	0.9	ns
$t_{sk(HL)}$¶					0.4	0.9	
$t_{sk(LH)}$¶	CLKAB/LEAB	B	Slow		0.5	1	ns
$t_{sk(HL)}$¶					0.5	1	
$t_{sk(LH)}$¶	CLKAB/LEAB	B	Fast		0.4	0.9	ns
$t_{sk(HL)}$¶					0.4	0.9	
$t_{sk(t)}$¶	AI	B	Slow		1.4	2	ns
			Fast		0.6	1.4	
	CLKAB/LEAB	B	Slow		1.8	2.5	
			Fast		0.9	1.8	

† Slow (ERC = L) and Fast (ERC = H)
‡ All typical values are at V_{CC} = 3.3 V, T_A = 25°C.
§ Actual skew values between the GTLP outputs could vary on the backplane due to the loading and impedance seen by the device.
¶ $t_{sk(LH)}$/$t_{sk(HL)}$ and $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs with the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in the same direction either high to low [$t_{sk(HL)}$] or low to high [$t_{sk(LH)}$] or in opposite directions, both low to high and high to low [$t_{sk(t)}$].

PARAMETER MEASUREMENT INFORMATION

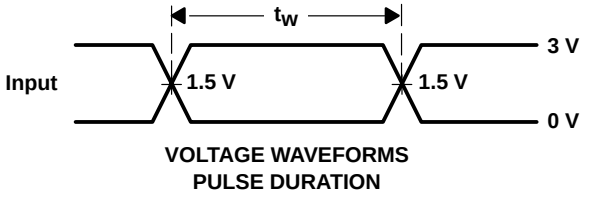


TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	6 V
t_{PHZ}/t_{PZH}	GND

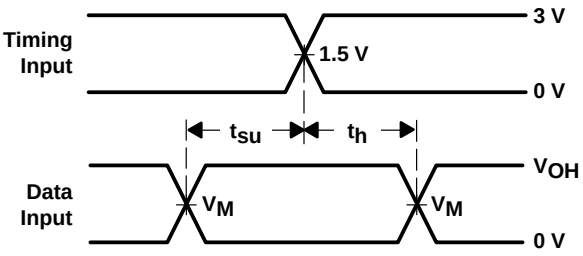


LOAD CIRCUIT FOR A OUTPUTS

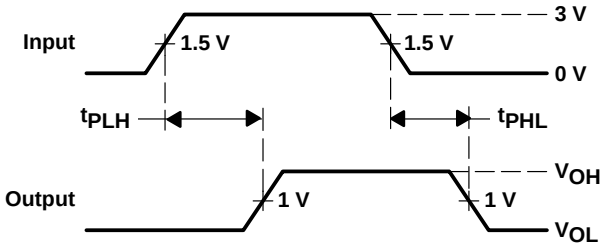
LOAD CIRCUIT FOR B OUTPUTS



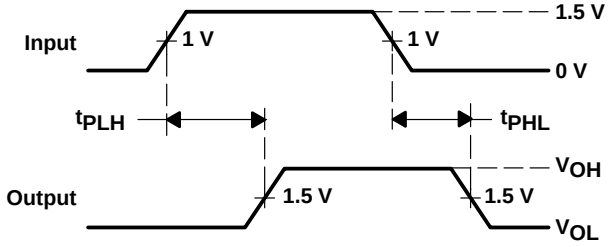
VOLTAGE WAVEFORMS
PULSE DURATION



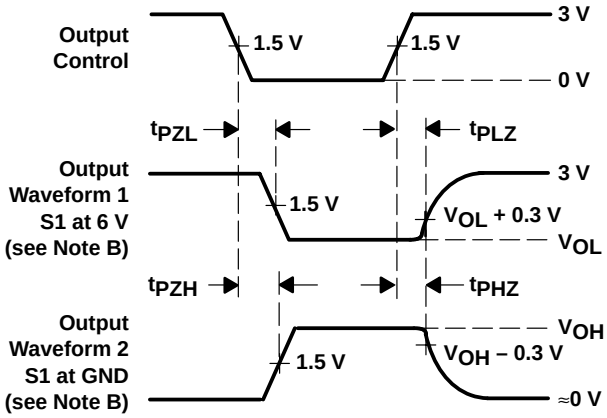
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES
(V_M = 1.5 V for A port and 1 V for B port)
(V_{OH} = 3 V for A port and 1.5 V for B port)



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
(AI to B port)



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
(B port to AO)



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
(AO)

NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: PRR ≈ 10 MHz, Z_O = 50 Ω, t_r ≈ 2 ns, t_f ≈ 2 ns.
D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

DISTRIBUTED-LOAD BACKPLANE SWITCHING CHARACTERISTICS

The preceding switching characteristics table shows the switching characteristics of the device into a lumped load (Figure 1). However, the designer's backplane application is probably a distributed load. The physical representation is shown in Figure 2. This backplane, or distributed load, can be closely approximated to a resistor inductance capacitance (RLC) circuit, as shown in Figure 3. This device has been designed for optimum performance in this RLC circuit. The following switching characteristics table shows the switching characteristics of the device into the RLC load, to help the designer to better understand the performance of the GTLP device in this typical backplane. See www.ti.com/sc/gtlp for more information.

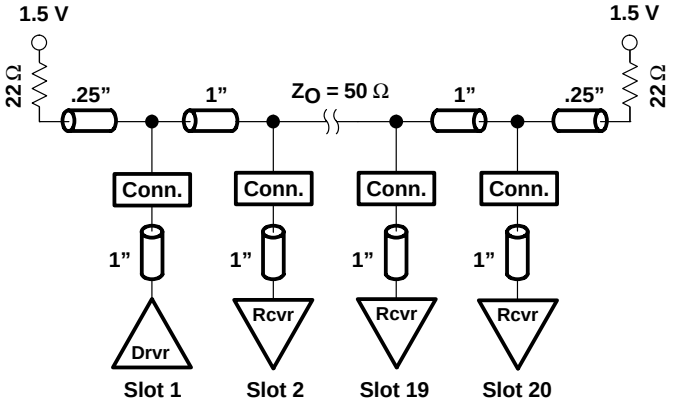


Figure 2. High-Drive Test Backplane

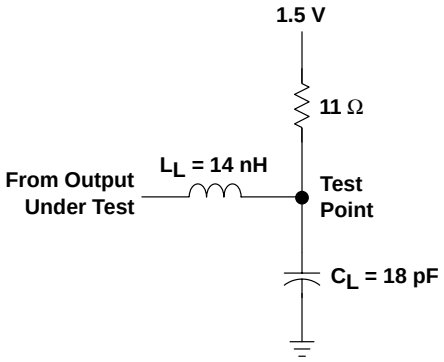


Figure 3. High-Drive RLC Network

switching characteristics over recommended operating conditions for the bus transceiver function (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATE†	TYP‡	UNIT
t_{PLH}	AI (buffer)	B	Slow	4.7	ns
t_{PHL}				5	
t_{PLH}	AI (buffer)	B	Fast	3.7	ns
t_{PHL}				4	
t_{PLH}	LEAB (latch mode)	B	Slow	5.5	ns
t_{PHL}				5.8	
t_{PLH}	LEAB (latch mode)	B	Fast	4.6	ns
t_{PHL}				4.8	
t_{PLH}	CLKAB (flip-flop mode)	B	Slow	5.8	ns
t_{PHL}				6	
t_{PLH}	CLKAB (flip-flop mode)	B	Fast	4.9	ns
t_{PHL}				4.9	
t_{PLH}	OMODE	B	Slow	5.5	ns
t_{PHL}				5.7	
t_{PLH}	OMODE	B	Fast	4.5	ns
t_{PHL}				4.7	
t_r	Rise time, B-port outputs (20% to 80%)		Slow	1.8	ns
			Fast	1.1	
t_f	Fall time, B-port outputs (80% to 20%)		Slow	3.4	ns
			Fast	2.6	

† Slow (ERC = H) and Fast (ERC = L)
‡ All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SN74GTLP22033DGGR	Active	Production	TSSOP (DGG) | 48	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	GTLP22033
SN74GTLP22033DGGR.B	Active	Production	TSSOP (DGG) | 48	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	GTLP22033

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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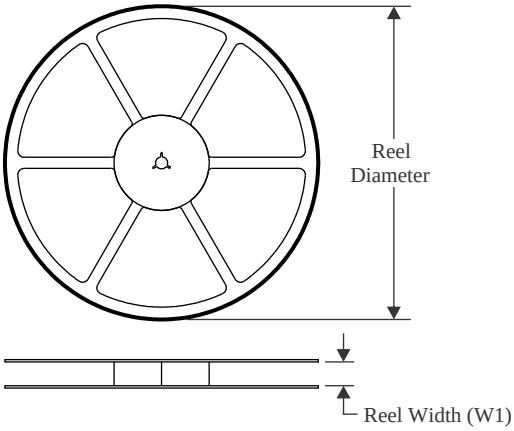
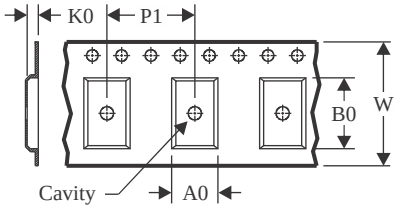
TAPE AND REEL INFORMATION

REEL DIMENSIONS

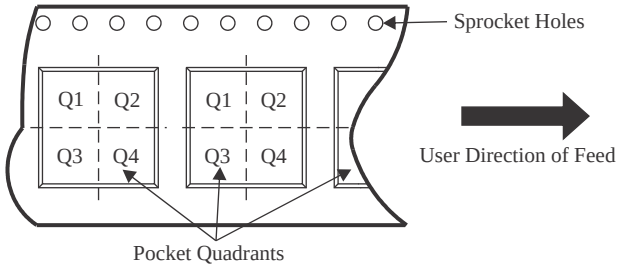


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

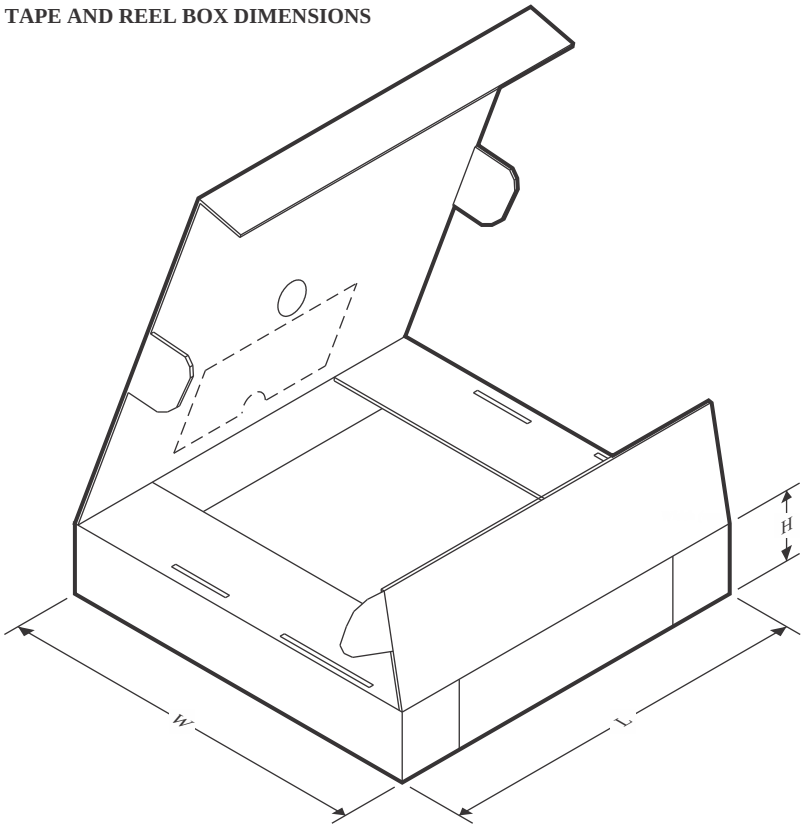
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

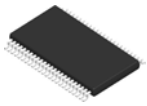
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74GTLP22033DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74GTLP22033DGGR	TSSOP	DGG	48	2000	356.0	356.0	45.0

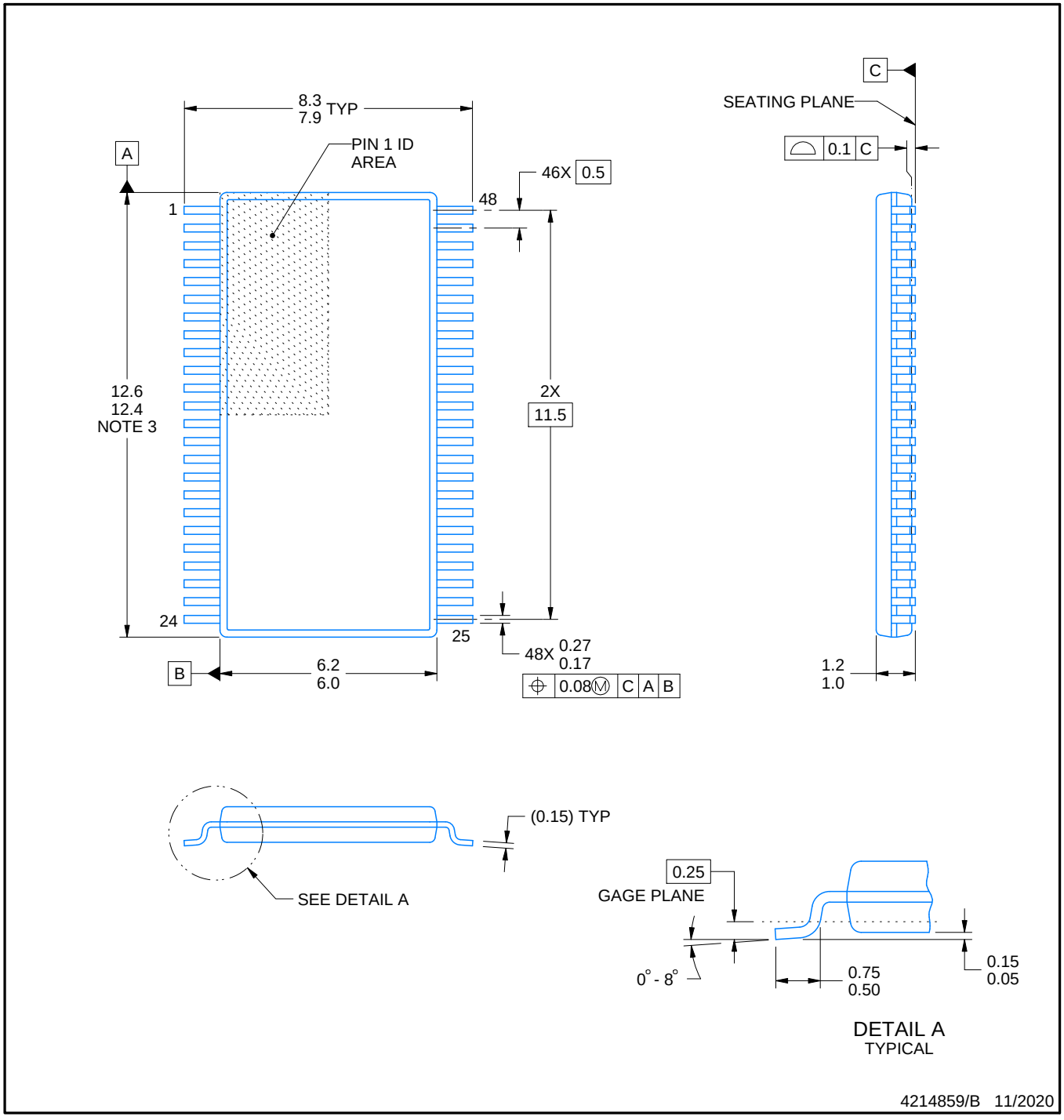


PACKAGE OUTLINE

DGG0048A

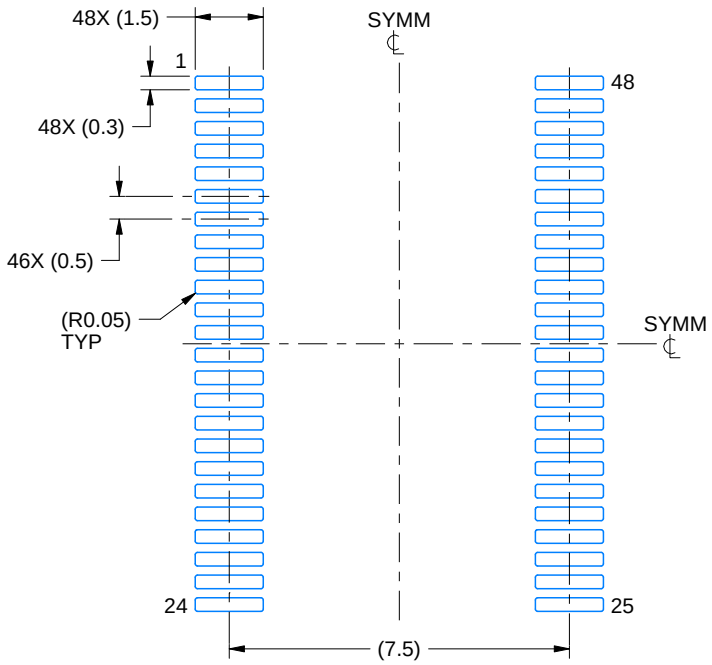
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

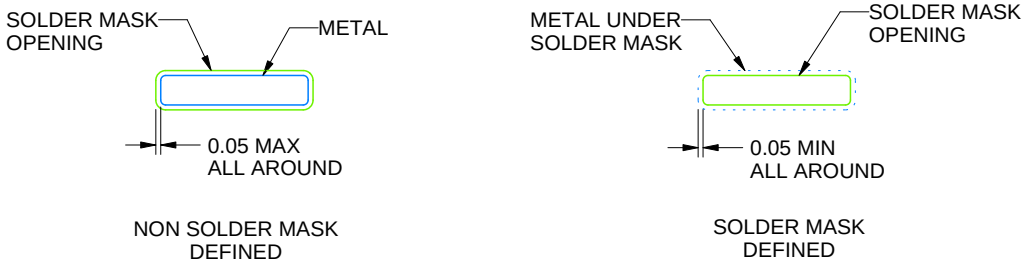


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-153.



LAND PATTERN EXAMPLE
SCALE:6X

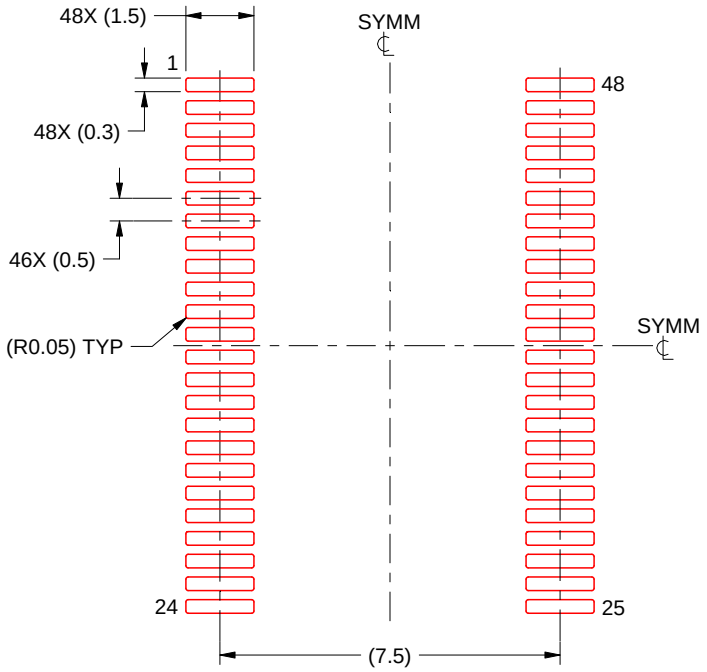


SOLDER MASK DETAILS

4214859/B 11/2020

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

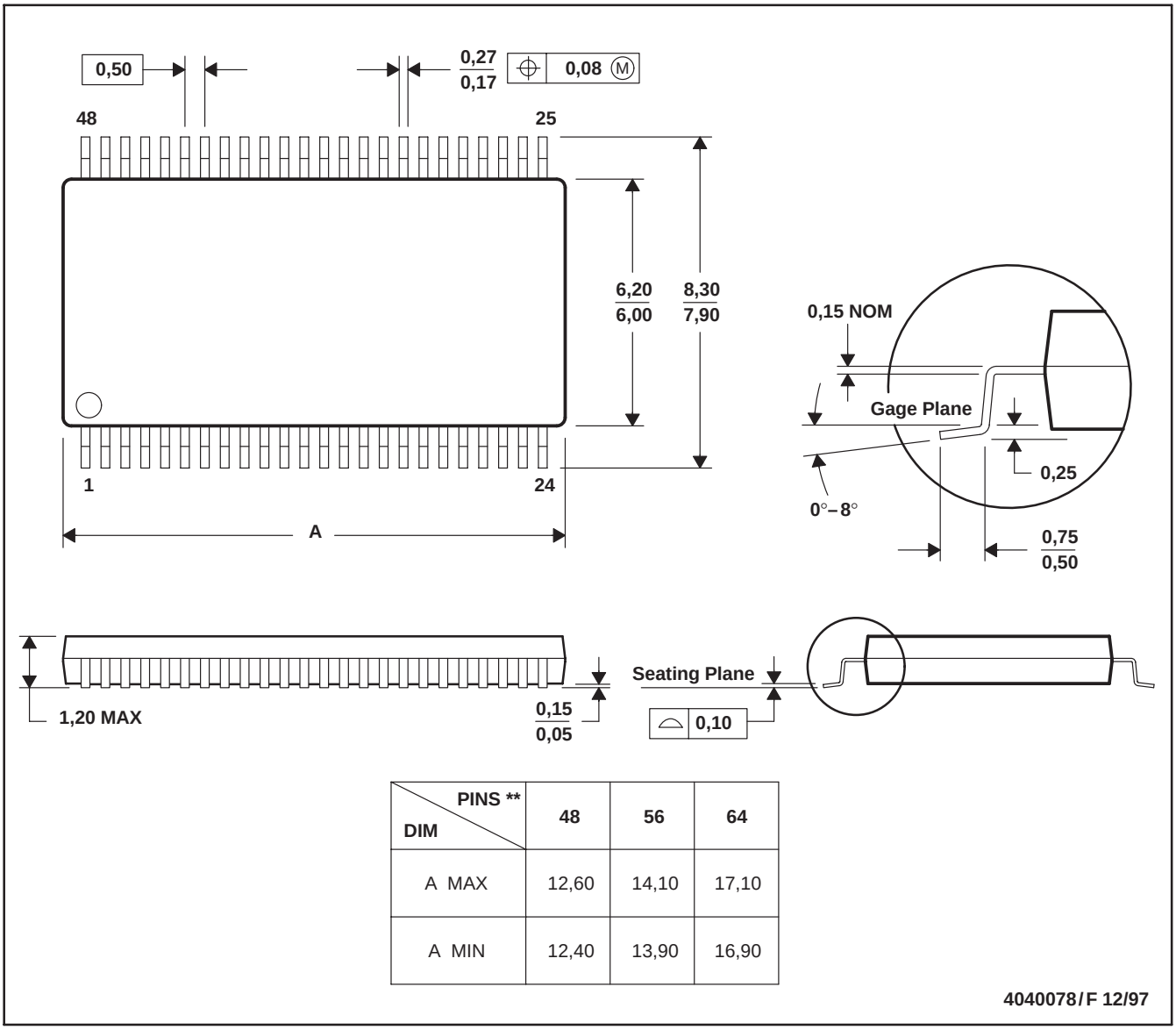
4214859/B 11/2020

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

DGG (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

48 PINS SHOWN



DIM \ PINS **	48	56	64
A MAX	12,60	14,10	17,10
A MIN	12,40	13,90	16,90

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold protrusion not to exceed 0,15.
D. Falls within JEDEC MO-153

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